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FORM PTO 1449 (modified)			ATTY DOCKET NO.: 50169/110	SER	SERIAL NO.: Je-be assigned			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			APPLICANT: Wallace TY. TANG					
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			FILING DATE: August 14, 1998		GROUP: John	aeeigned in the second		
Date Submitted to P	TO: August 14, 1998		U.S. PATENT DOCUMENTS					
*EXAMINER DOCUMENT DATE INITIAL NUMBER			NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
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FORM PTO 1449 (modified)			ATTY DOCKET NO.: 50169/110		SERIAL	NO.: To be?	Scor	ned -			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			APPLICANT: Wallace TY. TANG $09/34/47$,				
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: August 14, 1998			FILING DATE: August 14, 1998			GROUP: Jo bo assigned 1763					
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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.: 50169/110 SERIAL NO.: To be assigned 09/134/47						
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			APPLICANT: Wallace T.Y. TANG						
			FILING DATE: August 14, 1998 GROUP: 4768						
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